54ABT377 Octal D-Type Flip-Flop with Clock Enable

National Semiconductor

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General Description

The 'ABT377 has eight edge-triggered, D-type flip-flops with individual D inputs and Q outputs. The common buffered Clock (CP) input loads all flip-flops simultaneously, when the Clock Enable ($\overline{CE})$ is LOW.

The register is fully edge-triggered. The state of each D input, one setup time before the LOW-to-HIGH clock transition, is transferred to the corresponding flip-flop's Q output. The \overrightarrow{CE} input must be stable only one setup time prior to the LOW-to-HIGH clock transition for predictable operation.

Features

 Clock enable for address and data synchronization applications

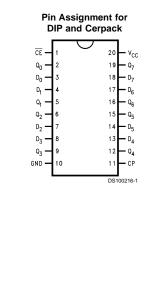
Eight edge-triggered D flip-flops

- Buffered common clock
- See 'ABT273 for master reset version
- See 'ABT373 for transparent latch version
- See 'ABT374 for TRI-STATE[®] version
- Output sink capability of 48 mA, source capability of 24 mA
- Guaranteed latchup protection
- High impedance glitch free bus loading during entire power up and power down cycle
- Non-destructive hot insertion capability
- Disable time less than enable time to avoid bus contention
- Standard Microcircuit Drawing (SMD) 5962-9314801

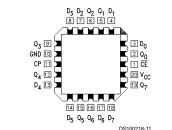
Ordering Code:

Military	Package	Package Description		
	Number			
54ABT377J-QML	J20A	20-Lead Ceramic Dual-In-Line		
54ABT377W-QML	W20A	20-Lead Cerpack		
54ABT377E-QML	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C		

Connection Diagram





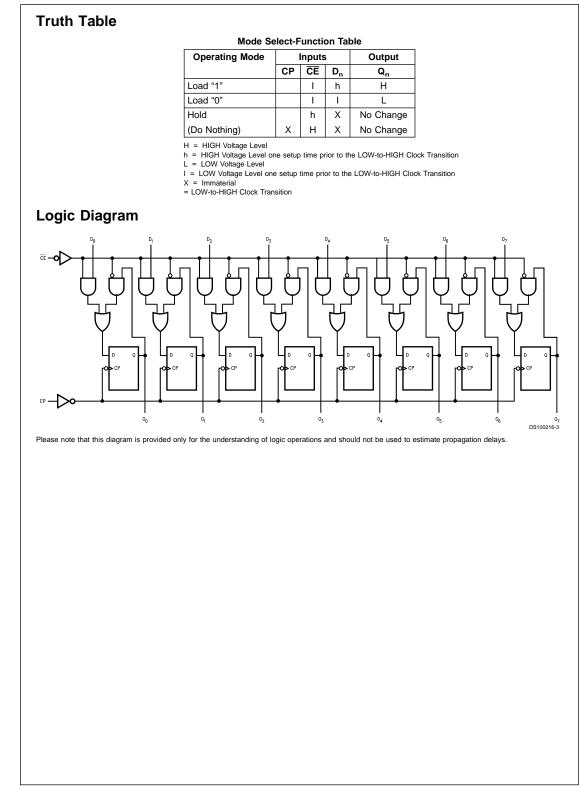


Pin	Description		
Names			
D ₀ –D ₇	Data Inputs		
CE	Clock Enable (Active LOW)		
CP	Clock Pulse Input		
00-	Data Outputs		

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Absolute Maximum Ratings (Note 1)

Storage Temperature	-65°C to +150°C
0 1	
Ambient Temperature under Bias	–55°C to +125°C
Junction Temperature under Bias	
Ceramic	–55°C to +175°C
V _{CC} Pin Potential to	
Ground Pin	-0.5V to +7.0V
Input Voltage (Note 2)	-0.5V to +7.0V
Input Current (Note 2)	-30 mA to +5.0 mA
Voltage Applied to Any Output	
in the Disabled or	
Power-Off State	-0.5V to +4.75V
in the HIGH State	-0.5V to V _{CC}
Current Applied to Output	
in LOW State (Max)	Twice the rated I_{OL} (mA)

DC Latchup Source Current (Across Comm Operating Range) Over Voltage Latchup

Recommended Operating Conditions

Free Air Ambient Temperature	
Military	–55°C to +125°C
Supply Voltage	
Military	+4.5V to +5.5V
Minimum Input Edge Rate	$(\Delta V/\Delta t)$
Data Input	50 mV/ns
Enable Input	20 mV/ns

–500 mA

 V_{CC} + 4.5V

DC Electrical Characteristics

Symbol	Parameter	Parameter		ABT377		Units	V _{cc}	Conditions
			Min	Тур	Max	1		
VIH	Input HIGH Voltage		2.0			V		Recognized HIGH Signal
VIL	Input LOW Voltage				0.8	V		Recognized LOW Signal
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	I _{IN} = -18 mA
V _{он}	Output HIGH Voltage	54ABT	2.5			V	Min	I _{он} = –3 mA
		54ABT	2.0					I _{он} = –24 mA
V _{OL}	Output LOW Voltage	54ABT			0.55	V	Min	I _{OL} = 48 mA
I _{IH}	Input HIGH Current				5	μA	Max	V _{IN} = 2.7V (Note 4)
					5			$V_{IN} = V_{CC}$
I _{BVI}	Input HIGH Current				7	μA	Max	V _{IN} = 7.0V
	Breakdown Test							
I _{IL}	Input LOW Current				-5	μA	Max	V _{IN} = 0.5V (Note 4)
					-5			$V_{IN} = 0.0V$
V _{ID}	Input Leakage Test		4.75			V	0.0	I _{ID} = 1.9 μA
								All Other Pins Grounded
los	Output Short-Circuit Current		-100		-275	mA	Max	V _{OUT} = 0.0V
I _{CEX}	Output High Leakage Currer	nt			50	μA	Max	$V_{OUT} = V_{CC}$
I _{CCH}	Power Supply Current				50	μA	Max	All Outputs HIGH
I _{CCL}	Power Supply Current				30	mA	Max	All Outputs LOW
I _{CCT}	Maximum I _{cc} /Input Ou	tputs Enabled						$V_{I} = V_{CC} - 2.1V$
					1.5	mA	Max	Data Input V _I = V _{CC} – 2.1V
								All Others at V_{CC} or GND
I _{CCD}	Dynamic I _{CC}	No Load			0.3	mA/	Max	Outputs Open (Note 3)
						MHz		One bit Toggling, 50% Duty Cycle

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Note 3: For 8 bits toggling, $I_{CCD} < 0.5$ mA/MHz.

Note 4: Guaranteed but not tested.

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Symbol	Parameter	$\frac{54ABT}{T_{A} = -55^{\circ}C \text{ to } +125^{\circ}C}$ $V_{CC} = 4.5V \text{ to } 5.5V$			
		С _L = 50 рF			
		Min	Max		
f _{max}	Max Clock	150		MHz	
	Frequency				
t _{PLH}	Propagation Delay	2.2	6.0	ns	
t _{PHL}	CP to O _n	2.8	6.8		

AC Operating Requirements

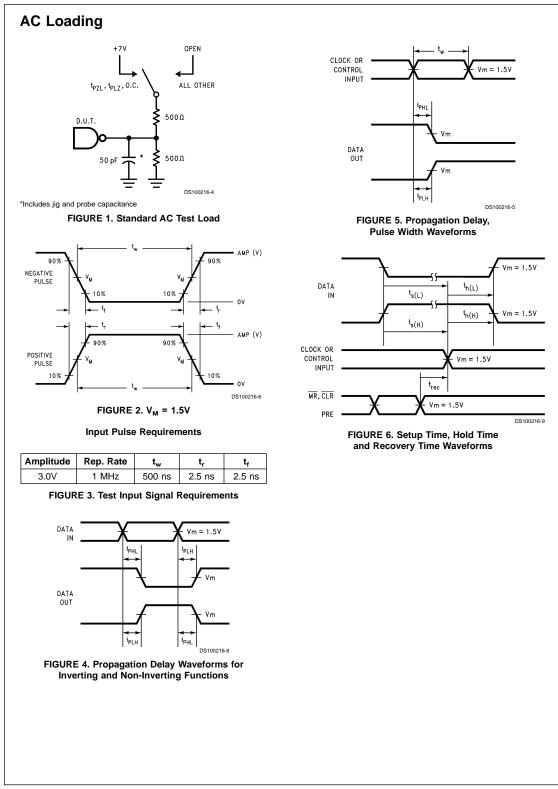
Symbol Parameter		54A T _A = -55°C V _{CC} = 4.5 C _L =	Units	
		Min	Max	
t _s (H)	Setup Time, HIGH	2.0		ns
t _s (L)	or LOW D _n to CP	2.0		
t _h (H)	Hold Time, HIGH	1.8		ns
t _h (L)	or LOW D _n to CP	1.8		
t _s (H)	Setup Time, HIGH	3.0		ns
t _s (L)	or LOW CE to CP	3.0		
t _h (H)	Hold Time, HIGH	1.0		ns
t _h (L)	or LOW CE to CP	1.0		
t _w (H)	Pulse Width, CP,	3.3		ns
t _w (L)	HIGH or LOW	3.3		

Capacitance

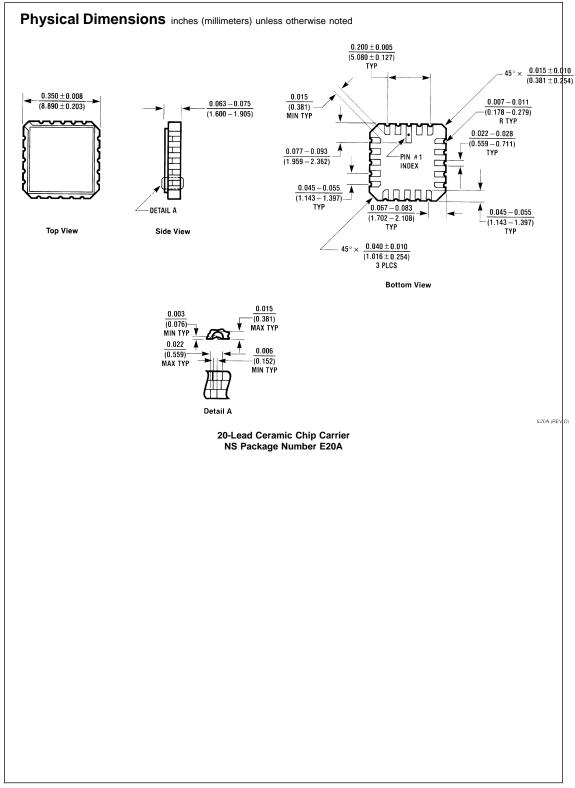
Symbol	Parameter	Тур	Units	Conditions
C _{IN}	Input Capacitance	5	pF	$V_{CC} = 0V, T_{A} = 25^{\circ}C$
C _{OUT} (Note 5)	Output Capacitance	9	pF	V _{CC} = 5.0V

Note 5: C_{OUT} is measured at frequency f = 1 MHz, per MIL-STD-883B, Method 3012.

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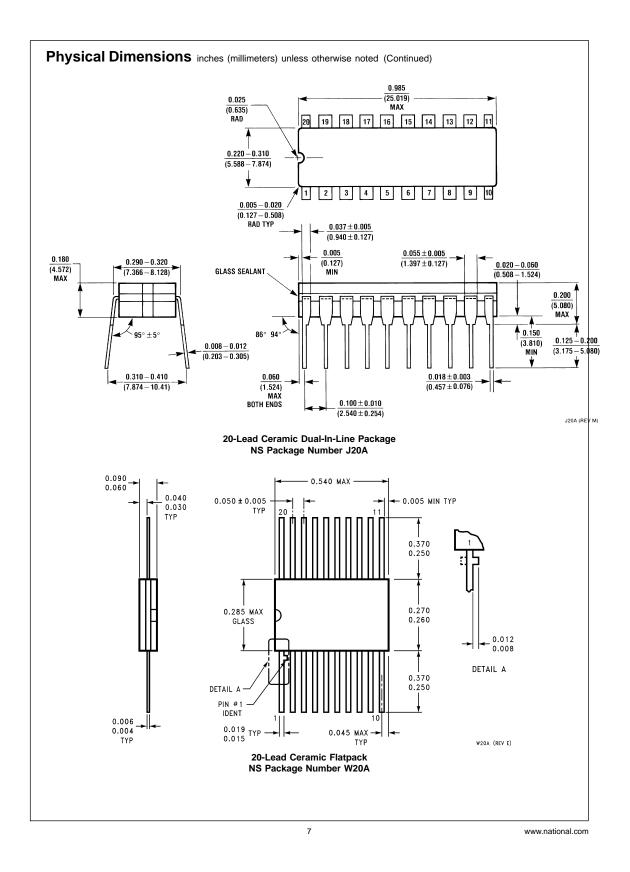


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Tel: 1-800-272-9959	Email: europe.support@nsc.com	Tel: 65-2544466	Fax: 81-3-5620-6179
Fax: 1-800-737-7018	Deutsch Tel: +49 (0) 1 80-530 85 85	Fax: 65-2504466	
Email: support@nsc.com	English Tel: +49 (0) 1 80-532 78 32	Email: sea.support@nsc.com	
	Français Tel: +49 (0) 1 80-532 93 58		
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